Triacs BT138X series

GENERAL DESCRIPTION

Passivated triacs in a full pack plastic envelope, intended for use in applications requiring high bidirectional transient and blocking voltage capability and high thermal cycling performance. Typical applications include motor control, industrial and domestic lighting, heating and static switching.

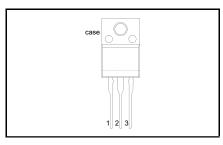
QUICK REFERENCE DATA

SYMBOL	PARAMETER	MAX.	MAX.	UNIT
	BT138X- BT138X-	600 600F	800 800F	
V_{DRM}	Repetitive peak off-state voltages	600	800	V
I _{T(RMS)} I _{TSM}	RMS on-state current Non-repetitive peak on-state current	12 95	12 95	A A

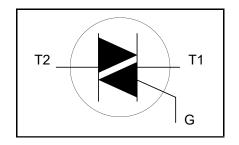
PINNING - SOT186A

PIN	DESCRIPTION
1	main terminal 1
2	main terminal 2
3	gate
case	isolated

PIN CONFIGURATION



SYMBOL



LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MA	λX.	UNIT
V_{DRM}	Repetitive peak off-state voltages		-	-600 600 ¹	-800 800	V
$I_{T(RMS)}\\I_{TSM}$	RMS on-state current Non-repetitive peak on-state current	full sine wave; T _{hs} ≤ 56 °C full sine wave; T _j = 25 °C prior to surge	-	1:		А
		t = 20 ms	-	9:		A
l²t dl _⊤ /dt	l ² t for fusing Repetitive rate of rise of on-state current after	t = 16.7 ms t = 10 ms $I_{TM} = 20 \text{ A}; I_G = 0.2 \text{ A};$ $dI_G/dt = 0.2 \text{ A}/\mu\text{s}$	-	10 4:		A A ² s
	triggering	T2+ G+ T2+ G- T2- G- T2- G+	- - -	5) 5) 5) 1)	0 0	A/µs A/µs A/µs A/µs
I _{GM} V _{GM} P _{GM}	Peak gate current Peak gate voltage Peak gate power		- - -	2	<u> </u>	V W
P _{G(AV)} T _{stg} T _j	Average gate power Storage temperature Operating junction temperature	over any 20 ms period	-40 -	0. 15 12	50	Ç Ç

¹ Although not recommended, off-state voltages up to 800V may be applied without damage, but the triac may switch to the on-state. The rate of rise of current should not exceed 15 A/ μ s.

Triacs BT138X series

ISOLATION LIMITING VALUE & CHARACTERISTIC

 T_{hs} = 25 $^{\circ}$ C unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{isol}	R.M.S. isolation voltage from all three terminals to external heatsink	f = 50-60 Hz; sinusoidal waveform; R.H. ≤ 65% ; clean and dustfree	ı	ı	2500	>
C _{isol}	Capacitance from T2 to external heatsink	f = 1 MHz	-	10	-	pF

THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
R _{th j-hs}	Thermal resistance junction to heatsink	full or half cycle with heatsink compound without heatsink compound			4.0 5.5	K/W K/W
R _{th j-a}	Thermal resistance junction to ambient	in free air	-	55	-	K/W

STATIC CHARACTERISTICS

T_i = 25 °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MA	AX.	UNIT
1	Gate trigger current	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}$				F	
I _{GT}	Gate trigger current	T2+ G+	_	5	35	25	mA
		T2+ G-	-	8	35	25	mA
		T2- G- T2- G+	<u>-</u>	10 22	35 70	25 70	mA mA
I_{L}	Latching current	$V_D = 12 \text{ V}; I_{GT} = 0.1 \text{ A}$					
_		T2+ G+	-	7	40	40	mA
		T2+ G-	-	20	60	60	mA
		T2- G- T2- G+	-	8 10	40 60	40 60	mA mA
I_{H}	Holding current	$V_D = 12 \text{ V}; I_{GT} = 0.1 \text{ A}$	-	6	30	30	mA
V_T	On-state voltage	I _τ = 15 A	_	1.4	1.	65	V
$V_{GT}^{'}$	Gate trigger voltage	$\dot{V}_{D} = 12 \text{ V}; I_{T} = 0.1 \text{ A}$	-	0.7		.5	V
		$V_D = 400 \text{ V}; I_T = 0.1 \text{ A};$	0.25	0.4	,	-	V
I_D	Off-state leakage current	$T_{i} = 125 ^{\circ}\text{C}$ $V_{D} = V_{DRM(max)};$ $T_{i} = 125 ^{\circ}\text{C}$	-	0.1	0	.5	mA

Triacs BT138X series

DYNAMIC CHARACTERISTICS

T_i = 25 °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MI	N.	TYP.	MAX.	UNIT
dV _D /dt	Critical rate of rise of off-state voltage	BT138X- $V_{DM} = 67\% V_{DRM(max)};$ $T_{i} = 125 ^{\circ}C;$ exponential	 100	F 50	250	-	V/µs
dV _{com} /dt	Critical rate of change of commutating voltage	waveform; gate open circuit $V_{DM} = 400 \text{ V}; T_j = 95 ^{\circ}\text{C};$ $I_{T(RMS)} = 12 \text{ A};$ $dI_{com}/dt = 5.4 \text{ A/ms};$ gate	-	-	20	-	V/µs
\mathbf{t}_{gt}	Gate controlled turn-on time	open circuit $I_{TM} = 16 \text{ A}; V_D = V_{DRM(max)}; I_G = 0.1 \text{ A}; dI_G/dt = 5 \text{ A/µs}$	-	1	2	-	μs

Triacs BT138X series

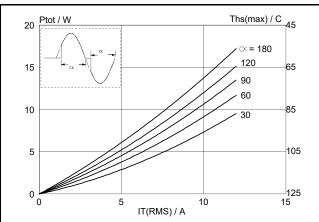


Fig.1. Maximum on-state dissipation, P_{tot} , versus rms on-state current, $I_{T(RMS)}$, where α = conduction angle.

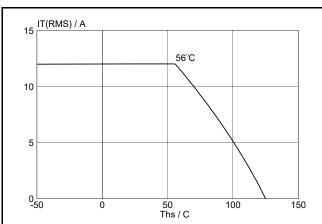


Fig.4. Maximum permissible rms current $I_{\text{T(RMS)}}$, versus heatsink temperature T_{hs} .

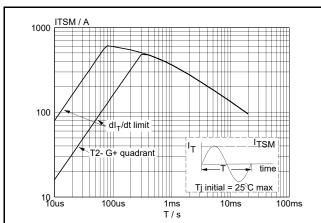


Fig.2. Maximum permissible non-repetitive peak on-state current I_{TSM} , versus pulse width t_p , for sinusoidal currents, $t_p \le 20$ ms.

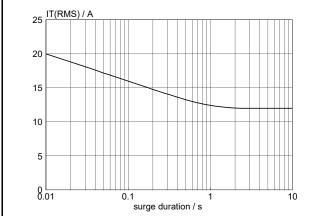


Fig.5. Maximum permissible repetitive rms on-state current $I_{T(RMS)}$, versus surge duration, for sinusoidal currents, f = 50 Hz; $T_{hs} \leq 56$ °C.

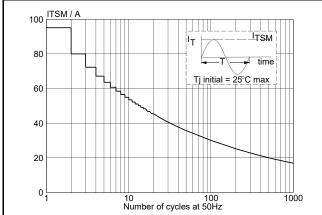


Fig.3. Maximum permissible non-repetitive peak on-state current I_{TSM} , versus number of cycles, for sinusoidal currents, f = 50 Hz.

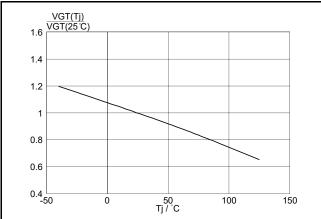
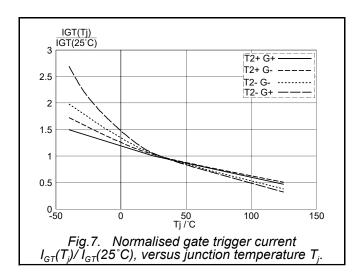
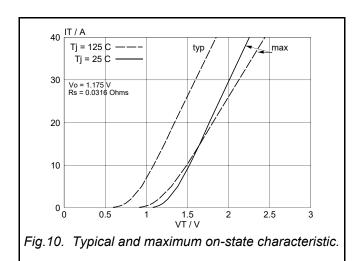
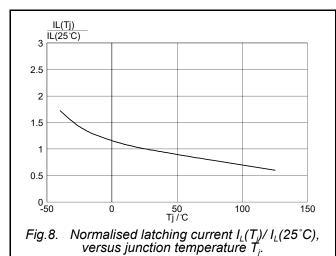


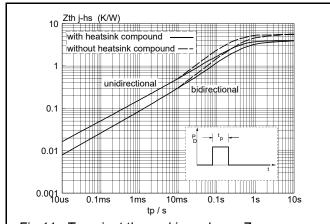
Fig. 6. Normalised gate trigger voltage $V_{GT}(T_j)/V_{GT}(25^{\circ}C)$, versus junction temperature T_j .

Triacs BT138X series









IH(Tj) IH(25°C 3 1 0.5 0 -50 150

Fig.11. Transient thermal impedance $Z_{th j-hs}$, versus pulse width t_o.

off-state dV/dt limit

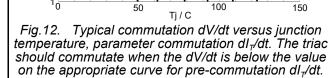
dV/dt (V/us)

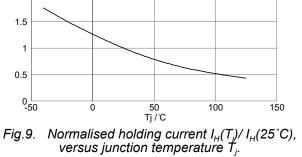
dlcom/dt = 15 A/ms

1000

100

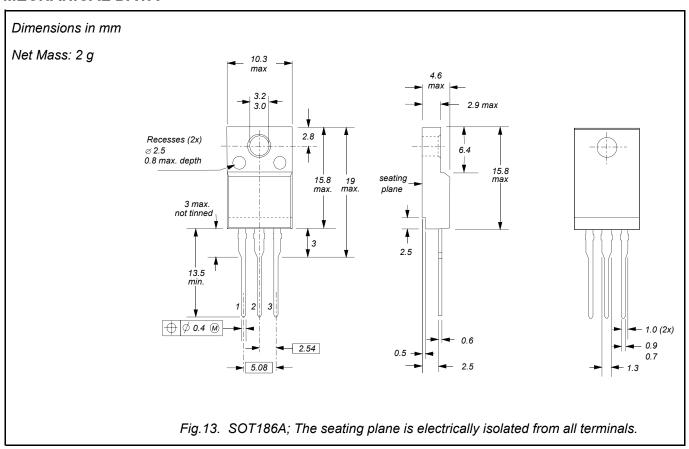
10





Triacs BT138X series

MECHANICAL DATA



- Notes
 1. Refer to mounting instructions for F-pack envelopes.
 2. Epoxy meets UL94 V0 at 1/8".

Triacs BT138X series

DEFINITIONS

DATA SHEET STATUS					
DATA SHEET STATUS ²	PRODUCT STATUS ³	DEFINITIONS			
Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice			
Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in ordere to improve the design and supply the best possible product			
Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Changes will be communicated according to the Customer Product/Process Change Notification (CPCN) procedure SNW-SQ-650A			

Limiting values

Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information

Where application information is given, it is advisory and does not form part of the specification.

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³ The product status of the device(s) described in this datasheet may have changed since this datasheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.